SWITCHMODE[™] Series **NPN Silicon Power Transistors**

These transistors are designed for high-voltage, high-speed switching of inductive circuits where fall time and RBSOA are critical. They are particularly well-suited for line-operated switchmode applications.

The MJE16004 is a high-gain version of the MJE16002 and MJH16002 for applications where drive current is limited.

Typical Applications:

- Switching Regulators
- High Resolution Deflection Circuits
- Inverters
- Motor Drives
- Fast Switching Speeds



ON Semiconductor®

http://onsemi.com

5.0 AMPERE **NPN SILICON POWER TRANSISTORS 450 VOLTS, 80 WATTS**



MAXIMUM RATINGS

Fast Switching Speeds 50 ns Inductive Fall Time @ 75°C (Typ) 70 ns Crossover Time @ 75°C (Typ) • 100°C Performance Specified for: Reverse–Biased SOA Inductive Switching Times Saturation Voltages Leakage Currents Rating Symbol Value Unit						
Rating	Symbol	Value	Unit			
Collector-Emitter Voltage	V _{CEO(sus)}	450	Vdc			
Collector-Emitter Voltage	V _{CEV}	850	Vdc			
Emitter-Base Voltage	V _{EB}	6.0	Vdc			
			Adc			
Base Current — Continuous — Peak (1)	I _B	4.0 8.0	Adc			
Total Power Dissipation @ T_C = 25°C @ T_C = 100°C Derate above T_C = 25°C	P _D	80 32 0.64	Watts W/°C			
Operating and Storage Junction Temperature Range	T _J , T _{stg}	-65 to +150	°C			

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	$R_{ heta JC}$	1.56	°C/W
Lead Temperature for Soldering Purposes: 1/8" from Case for 5 Seconds	T _L	275	°C

1

Preferred devices are ON Semiconductor recommended choices for future use and best overall value

⁽¹⁾ Pulse Test: Pulse Width = 5 ms, Duty Cycle ≤ 10%.

tic	Symbol	Min	Тур	Max	Unit
	•		•	•	•
e 2)	V _{CEO(sus)}	450	_	_	Vdc
= 100°C)	I _{CEV}	_	_ _	0.25 1.5	mAdd
C)	I _{CER}	_	_	2.5	mAdo
f Current I _{EBO} Vdc, I _C = 0)		_	_	1.0	mAdd
			1		•
Base Forward Biased	I _{S/b}		See Figure	e 17 or 18	
e Biased	RBSOA		See Fig	ure 19	
	I				
	VCE(sat)	 		1.0 1.0 2.5 2.5 2.5 2.5	Vdc
	V _{BE(sat)}	_ _ _ _	_ _ _ _	1.5 1.5 1.5 1.5	Vdc
MJE16002 MJE16004	h _{FE}	5.0 7.0	_	_	_
			1		1
	C _{ob}		_	200	pF
/MJH10002					
	t _d		30	100	ns
(lp2 = 0.8 Adc.	t _r		100	300	
$R_{B2} = 8.0 \Omega$)		_	1000	3000	
	t _f	_	60	300	
	+		400	_	1
$(V_{BE(off)} = 5.0 \text{ Vdc})$		_	130	_	1
MJH16004	<u> </u>		1	I	1
	t _d	_	30	100	ns
$(I_{B2} = 0.6 \text{ Adc})$		_	130	300	1
$R_{B2} = 8.0 \Omega$		_	800	2700	1
		_	80	350	1
(V _{BE(off)} = 5.0 Vdc)	t _s	_	250	_	1
	MJE16004 MJE16002 MJE16002 MJE16004 MJE16002 MJE16002 MJE16002 MJE16004 MJE16002 MJE16004 MJE16004 MJE16004 MJE16004 MJE16004 (I _{B2} = 0.8 Adc, R _{B2} = 8.0 Ω) (V _{BE(off)} = 5.0 Vdc) MJH16004 (I _{B2} = 0.6 Adc, R _{B2} = 8.0 Ω)	Page Company Compan	E 2 VCEO(sus) 450 CEV	Page Page	Part Variety Variet

Fall Time (1) Pulse Test: PW = 300 μ s, Duty Cycle \leq 2%.

SWITCHING CHARACTERISTICS (continued)

Characteristics			Symbol	Min	Тур	Max	Unit
Inductive Load (Table	2) MJE16002						
Storage Time			t _{sv}	_	500	1600	ns
Fall Time	(I 0.0 Ado	(T _J = 100°C)	t _{fi}	_	100	200	
Crossover Time	(I _C = 3.0 Adc, I _{B1} = 0.4 Adc, V _{BE(off)} = 5.0 Vdc, V _{CE(pk)} = 400 Vdc)		t _c	_	120	250	
Storage Time			t _{sv}	_	600	_	
Fall Time		(T _J = 150°C)	t _{fi}	_	120	_	
Crossover Time			t _c	_	160	_	
Inductive Load (Table	2) MJE16004						
Storage Time	(I _C = 3.0 Adc, I _{B1} = 0.3 Adc, V _{BE(off)} = 5.0 Vdc, V _{CE(pk)} = 400 Vdc)		t _{sv}	_	400	1300	ns
Fall Time		(T _J = 100°C)	t _{fi}	_	80	150	
Crossover Time			t _c	_	90	200	
Storage Time			t _{sv}	_	450	_	1
Fall Time		(T _J = 150°C)	t _{fi}	_	100	_	1
Crossover Time			t _c	_	110	_	

⁽¹⁾ Pulse Test: PW = 300 μ s, Duty Cycle \leq 2%.

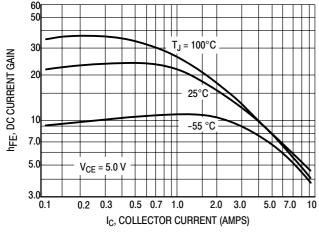


Figure 1. DC Current Gain

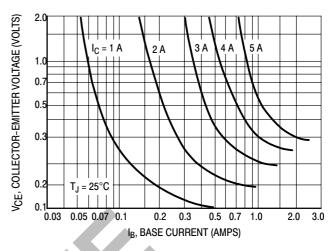


Figure 2. Collector Saturation Region

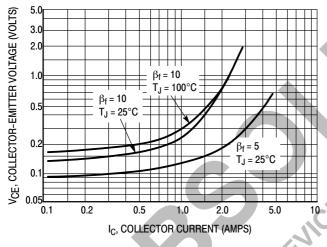


Figure 3. Collector–Emitter Saturation Region

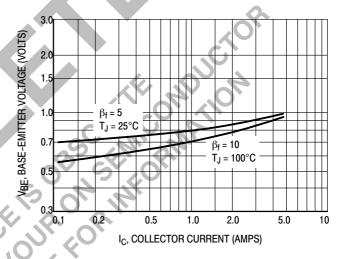


Figure 4. Base-Emitter Voltage

TYPICAL STATIC CHARACTERISTICS (continued)

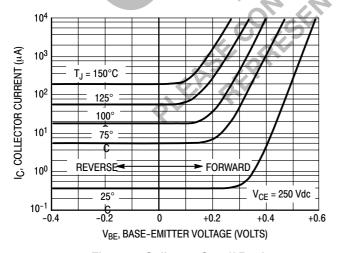


Figure 5. Collector Cutoff Region

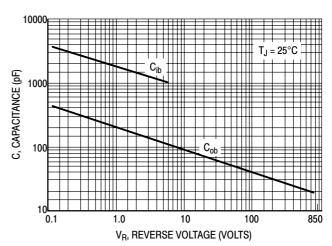


Figure 6. Capacitance

TYPICAL DYNAMIC CHARACTERISTICS

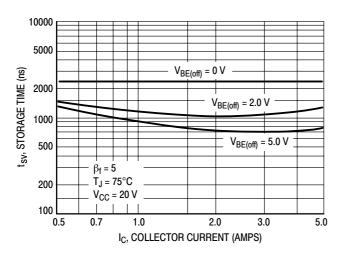


Figure 7. Storage Time

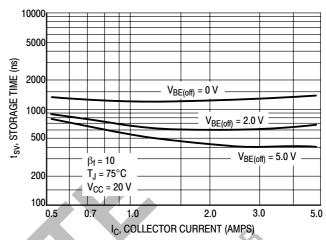


Figure 8. Storage Time

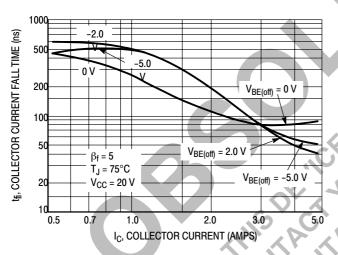


Figure 9. Collector Current Fall Time

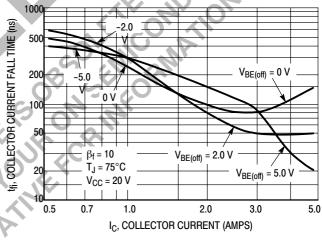


Figure 10. Collector Current Fall Time

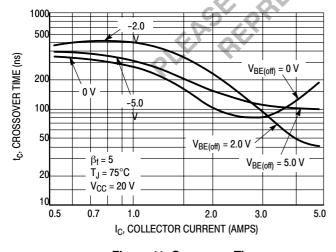


Figure 11. Crossover Time

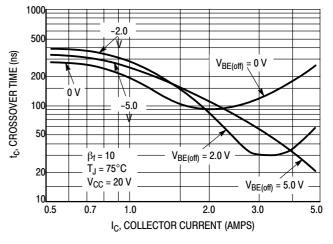
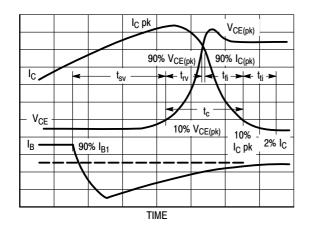


Figure 12. Crossover Time

TYPICAL ELECTRICAL CHARACTERISTICS



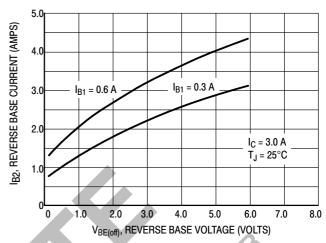


Figure 13. Inductive Switching Measurements

Figure 14. Peak Reverse Base Current

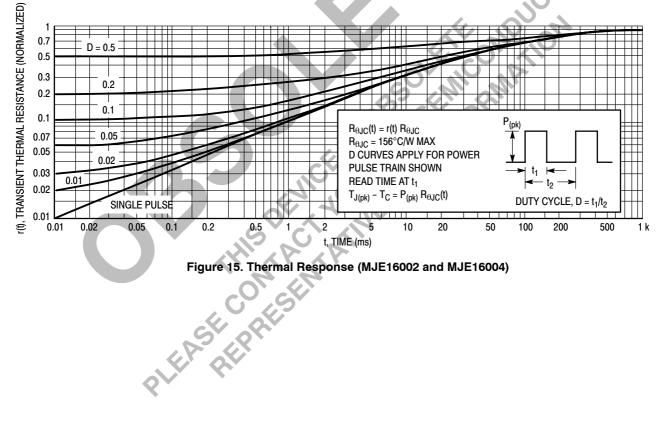
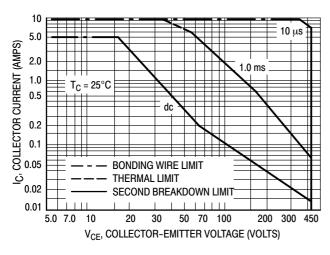


Figure 15. Thermal Response (MJE16002 and MJE16004)

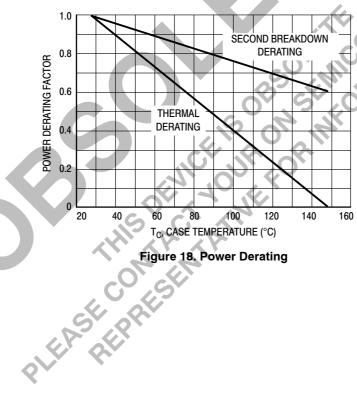
SAFE OPERATING AREA INFORMATION



10 9.0 C(pk), COLLECTOR CURRENT (AMPS) $\beta_f \ge 4$ T_J ≤ 8.0 100°C 7.0 6.0 5.0 4.0 3.0 2.0 $V_{BE(off)} = 0 V$ $V_{BE(off)}$ = 1.0 to 5.0 V 1.0 0 100 200 500 700 850 1000 V_{CE(pk)}, PEAK COLLECTOR-EMITTER VOLTAGE (VOLTS)

Figure 16. Maximum Rated Forward Bias Safe Operating Area (MJE16002 and MJE16004)

Figure 17. Maximum Rated Reverse Bias Safe Operating Area



SAFE OPERATING AREA INFORMATION

FORWARD BIAS

There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate I_C – V_{CE} limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate.

The data of Figure 16 is based on $T_C = 25^{\circ}C$; $T_{J(pk)}$ is variable depending on power level. Second breakdown pulse limits are valid for duty cycles to 10% but must be derated when $T_C \ge 25^{\circ}C$. Second breakdown limitations do not derate the same as thermal limitations. Allowable current at the voltages shown on Figures 17 and 18 may be found at any case temperature by using the appropriate curve on Figure 20.

PIERSE GREEFER ATIVE TO BE A SERVED $T_{J(pk)}$ may be calculated from the data in Figure 15. At high case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown.

REVERSE BIAS

For inductive loads, high voltage and high current must be sustained simultaneously during turn-off, in most cases, with the base-to-emitter junction reverse biased. Under these conditions the collector voltage must be held to a safe level at or below a specific value of collector current. This can be accomplished by several means such as active clamping, RC snubbing, load line shaping, etc. The safe level for these devices is specified as Reverse Bias Safe operating Area and represents the voltage-current condition allowable pulling reverse biased turn-off. This rating is verified under clamped conditions so that the device is never subjected to an avalanche mode. Figure 17 gives the RBSOA characteristics.

Table 1. Resistive Load Switching

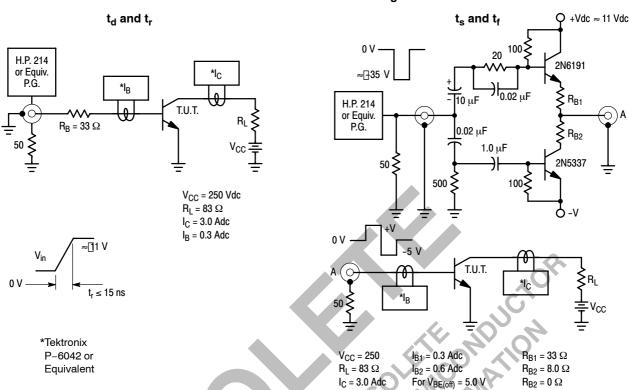
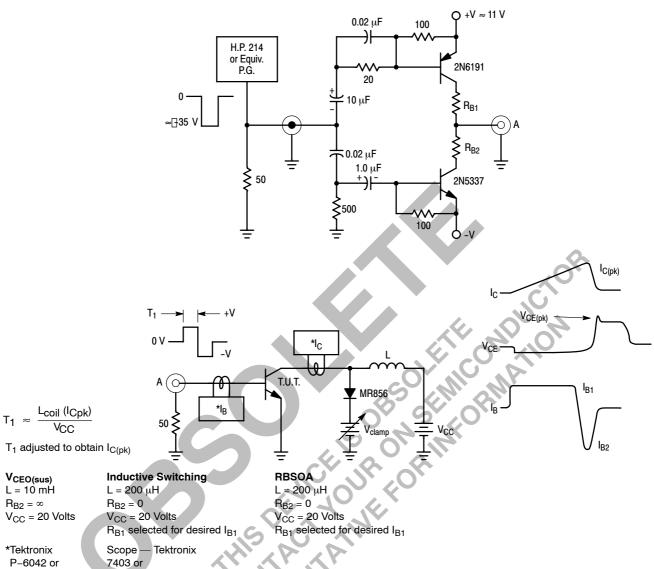
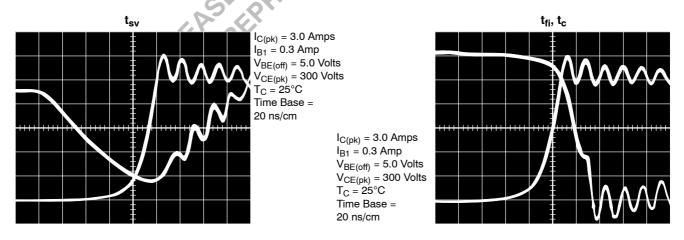


Table 2. Inductive Load Switching



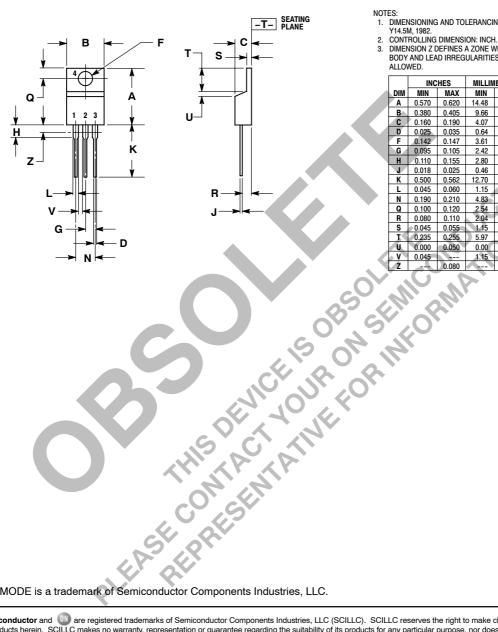
Equivalent Equivalent Note: Adjust - V to obtain desired V_{BE(off)} at Point A.

TYPICAL INDUCTIVE SWITCHING WAVEFORMS



PACKAGE DIMENSIONS

TO-220AB CASE 221A-09 ISSUE AA



NOTES

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: INCH.
- DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE

	INC	HES	MILLIN	IETERS	
DIM	MIN	MAX	MIN	MAX	
Α	0.570	0.620	14.48	15.75	
В	0.380	0.405	9.66	10.28	
C	0.160	0.190	4.07	4.82	
D	0.025	0.035	0.64	0.88	
F	0.142	0.147	3.61	3.73	
G	0.095	0.105	2.42	2.66	
Н	0.110	0.155	2.80	3.93	n
J	0.018	0.025	0.46	0.64	d
K	0.500	0.562	12.70	14.27	
L	0.045	0.060	1.15	1.52	
N	0.190	0.210	4.83	5.33	
Q	0.100	0.120	2.54	3.04	
R	0.080	0.110	2.04	2.79	
S	0.045	0.055	1.15	1.39	
I	0.235	0.255	5.97	6.47	
U	0.000	0.050	0.00	1.27	
٧	0.045		1.15		
Z	4	0.080		2.04	
K L N Q R S T U	0.500 0.045 0.190 0.100 0.080 0.045 0.235 0.000	0.562 0.060 0.210 0.120 0.110 0.055 0.255 0.050	12.70 1.15 4.83 2.54 2.04 1.15 5.97 0.00	14.27 1.52 5.33 3.04 2.79 1.39 6.47 1.27	

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